

EMC EMISSION - TEST REPORT

Report Number : 708881569801-00-Part 1 Date of Issue: June 15, 2015 Model XYZ (X stands for 1, 2, 3; Y stands for 0, 1, 2, 3, 4, 5, 6, 7, 8, 9; Z stands for 0, 1, 2, 3, 4, 5, 6, 7, 8, 9) Models list refer to Appendix B **Product Type** Flashlight **Applicant** Ningbo Strong Optoelectric Co., Ltd. Manufacturer Ningbo Strong Optoelectric Co., Ltd. License holder Ningbo Strong Optoelectric Co., Ltd. Address No.1, EAST YONGXING ROAD, EAST SUBURBS INDUSTRIAL ZONE 315499 YUYAO, ZHEJIANG, PEOPLE'S REPUBLIC OF CHINA

Test Result

■ Positive

■ Negative



Total pages including Appendices

28

TÜV SÜD CERTIFICATION AND TESTING (CHINA) CO., LTD. SHANGHAI BRANCH reports apply only to the specific samples tested under stated test conditions. Construction of the actual test samples has been documented. It is the manufacturer's responsibility to assure that additional production units of this model are manufactured with identical electrical and mechanical components. The manufacturer/importer is responsible to the Competent Authorities in Europe for any modifications made to the production units which result in non-compliance to the relevant regulations. TÜV SÜD Certification and Testing (China) Co., Ltd. Shanghai Branch shall have no liability for any deductions, inferences or generalizations drawn by the client or others from TÜV SÜD Certification and Testing (China) Co., Ltd. Shanghai Branch issued reports.

This report is the confidential property of the client. As a mutual protection to our clients, the public and ourselves, extracts from the test report shall not be reproduced except in full without our written approval.

Report Number: 708881569801-00-Part 1



DIRECTORY - EMISSIONS

A)	Documentation		Pages
,,,	200amomanon		
	Test Report		1 - 12
	Directory		2
	Test Regulations		3
	General Remarks and Summary		12
	Test Setups (Photographs)		13 - 16
B)	Test Data		
	Conducted Emissions	9/150 kHz - 30 MHz	5, 11
	Radiated Emissions	9 kHz - 30 MHz	6, 11
	Radiated Emissions	30 MHz – 300/1000/6000 MHz	7, 11
	Interference Power	30 MHz - 300 MHz	8, 11
	Harmonic Current Emissions and Voltage Fluctuations and Flicker	2nd through 40th Harmonics	9, 11
C)	Appendix A		
	Test Data Sheets		A2 – A6
D)	Appendix B		
	Constructional Data Form and Product Info	ormation Form(s)	B1 – B3
E)	Appendix C		
	Constructional Photographs		C1 – C3

Report Number: 708881569801-00-Part 1



EMISSIONS TEST REGULATIONS:

The emissions tests were performed according to the following regulations:

■ - EMC - Directive 2004/108/EC		
□ - EN 61000-6-3:2007/A1:2011		
□ - EN 61000-6-4:2007/A1:2011		
□- EN 61326-1:2006	□ - Class A	□ - Class B
□ - EN 55011:2009/A1:2010	□ - Group 1 □ - Class A	□ - Group 2 □ - Class B
□ - EN 55012:2007/A1:2009	_ 0.0007.	
□ - EN 55013:2013		
□ - EN 55014-1:2006/A1:2009/A2:2011	☐ - Household appliances a☐ - Electric tools☐ - Others	
■- EN 55015:2013		
□ - EN 55022: 2010	□ - Class A	□ - Class B
□- EN 61000-3-2:2006/A1:2009/A2:2009		
□ - EN 61000-3-3:2008 □ - EN 61000-3-11:2000		

Report Number: 708881569801-00-Part 1 Page 3 of 16



Environmental Conditions In The Laboratory:

Actual

Temperature: : 20°C
Relative Humidity: : 50%
Atmospheric Pressure: : 1005mBar

Power Supply Utilized:

Power supply system : 4.2V DC

Statement of Measurement Uncertainty:

For a 95% confidence level, the measurement uncertainties for defined systems are:-

Test Discipline	Frequency / Parameter	MU
Conducted Emission	0.15MHz to 30MHz	3.21 dB
Radiated Emission (Floatric field)	30MHz to 1GHz	3.46 dB (Horizontal)
Radiated Emission (Electric field)	30MH2 to TGH2	3.79 dB (Vertical)
Radiated Emission (Floatric field)	1GHz to 18GHz	3.33 dB (Horizontal)
Radiated Emission (Electric field)	IGHZ IO IOGHZ	3.58 dB (Vertical)
Radiated Emission (Magnetic field)	9KHz to 30MHz	3.03dB
Disturbance power	30MHz to 300MHz	2.99 dB
Harmonic	50Hz to 2KHz	6.21%
	dc	0.624%
Flicker	dmax	0.654%
FIICKEI	dt	4.729%
	Pst/Plt	4.73%

Symbol Definitions:

■ - Applicable

☐ - Not Applicable

Report Number: 708881569801-00-Part 1 Page 4 of 16



Emissions Test Conditions: CONDUCTED EMISSIONS (Interference Voltage)

The Conducted Emissions (Interference Voltage) measurements were performed at the following test location:

■ - Test not applicable

□ - Test Area –

Test Equipment Used:

	· =qa.po • • • • ·			
	Model Number	Manufacturer	Description	TUV PS Number
	DIA1512D	Schaffner	Discontinuous Interference Analyser	487/750206(No.E50)
□ -	ESHS30	Rohde & Schwarz	EMI Test Receiver	70-7/63-97-01
□ -		TÜV PS	Artificial Hand	95-01
	NSLK 8127	Schwarzbeck	LISN	48-7/60-02-15
□ -	ESH3-Z5	Rohde & Schwarz	LISN	70-7/60-96-03
□ -	ENV4200	Rohde & Schwarz	LISN	48-7/60-99-13
□ -	NNB42	Schaffner	LISN	487/601121
□ -	TK 9420	Schwarzbeck	High-Voltage-Probe, 1.5kOhm	487/430204
□ -	EN55015/B7	M&E	energy saving lamp active	707/609702

Remarks: Test equipment used is calibrated on a regular basis.

Report Number: 708881569801-00-Part 1 Page 5 of 16



Emissions Test Conditions: RADIATED EMISSIONS (Magnetic Field)

The RADIATED EMISSIONS (MAGNETIC FIELD) measurements were performed at the following test location:

☐ - Test not applicable

■ - Test Area-A

Testing was performed at a test distance of :

■ - 3 meters

□ - 30 meters

Test Equipment Used:

Model Number	Manufacturer	Description	TUV PS Number	
ESHS30	Rohde & Schwarz	EMI Test Receiver	70-7/63-97-01	
ESCI 3	Rohde & Schwarz	EMI Test Receiver	48-7/63-11-10	
HM020	Rohde & Schwarz	Triple-loop Antenna	48-7/62-99-11	

Remarks: Test equipment used is calibrated on a regular basis.

Report Number: 708881569801-00-Part 1 Page 6 of 16



Emissions Test Conditions: RADIATED EMISSIONS (Electric Field)

The RADIATED EMISSIONS (ELECTRIC FIELD) measurements, in the frequency range of 30 MHz-300/1000/6000 MHz, were tested in a horizontal and vertical polarization at the following test location:

□- Test not applicable

■ - Test Area - A

Testing was performed at a test distance of :

■ - 3 meters

□- 10 meters

Test Equipment Used:

Model Number	Manufacturer	Description	TUV PS Number
□ - ESIB7	Rohde & Schwarz	EMI Test Receiver (20Hz~7GHz)	487/630408
■ - ESU 8	Rohde & Schwarz	EMI Test Receiver	487/630909
■ - VULB9168	Schwarzbeck	Broadband Antenna	487/621027
□ - 10m	TDK	Semi-anechoic Chamber	487/770201
■ - 3m	Jinlida	Anechoic Chamber	

Remarks: Test equipment used is calibrated on a regular basis.

Report Number: 708881569801-00-Part 1 Page 7 of 16



Emissions Test Conditions: INTERFERENCE POWER

The INTERFERENCE POWER measurements were performed by using the absorbing clamp on the mains and interface cables in the frequency range 30 MHz - 300 MHz at the following test location:

■ - Test not applicable

□ - Test Area -

Test Equipment Used:

Model Number	Manufacturer	Description	TUV PS Number
□ - MDS-21	Rohde & Schwarz	Absorbing Clamp	70-7/60-95-02
□ - ESVS 30	Rhode & Schwarz	EMI Test Receiver	70-7/63-95-02

Remarks: Test equipment used is calibrated on a regular basis.

Report Number: 708881569801-00-Part 1 Page 8 of 16



Emissions Test Conditions: CONDUCTED EMISSIONS (Harmonics and Flicker)

The Harmonic Current Emissions and Voltage Fluctuations and Flicker measurements were performed at the following test location :

■ - Test not applicable

□ - Test Area -

Test Equipment Used:

	Model Number	Manufacturer	Description	TUV PS Number
□ -	PM 6000	Voltech	Universal Power Analyzer	48-7/74-07-41
□ -	IEC Standard 555	Voltech	Reference Impedance Network	70-7/57-95-01
□ -	C15003ix-400/3-CTS	California Instruments	AC Power Supply Testing System	487/68-99-10
□ -	MX45-3PI	California Instruments	AC Power Supply Testing System	487/681243

Remarks: Test equipment used is calibrated on a regular basis.

Report Number: 708881569801-00-Part 1 Page 9 of 16



Equipment Under Test (EUT) Test Operation Mode - Emissions Tests:

The equipment under test was operated under the following conditions during emissions testing:		
□ - Standby		
□ - Test Program (H - Pattern)		
□ - Test Program (Color Bar)		
□ - Test Program (Customer Spe	eified)	
■ - Normal Operating Mode		
■ - Light on.		_
Configuration of the equipment	under test:	_
■ - See Constructional Data Form		
■ - See Product Information Form		
The following peripheral device	s and interface cables were connected during the testing:	
□ - <u> </u>	Туре :	_
-		_
-	Type :	_
-		
□ - <u> </u>		
-		
-	Type :	
□ - unshielded power cable		
□ - unshielded cables		
□ - shielded cables	TUVPS.No.:	
☐ - customer specific cables		
-		
_		

Report Number: 708881569801-00-Part 1 Page 10 of 16



Emissions Test Results:

Conducted Emissions, 9/150 kHz - 30 N	lHz			
□ - PASS	🗆 - FAIL	■ - NOT	APPLICABLE	
Minimum limit margin		dB	At	MHz
Maximum limit exceeding		dB	At	MHz
Remarks:				
				·
Radiated Emissions (Magnetic Field), 9				
■ - PASS	□ - FAIL	□ - NOT	APPLICABLE	•
Minimum limit margin		<u>>6</u> dB	At <u>0.009-30</u>	MHz
Maximum limit exceeding		dB	At	MHz
Remarks:				
Interference Power at the Mains and Int	arface Cables	20 MH - 200 MH-		
□ - PASS	- FAIL		APPLICABLE	
	LI - I AIL			
Minimum limit margin		dB	<u> </u>	
Maximum limit exceeding		dB		
Comply with the limits reduces by Table 2	b of EN 55014-1	? □ - YES □	l - NO	■ - N/A
Remarks:				
Radiated Emissions (Electric Field),	· 30 MHz – 300 I	MHz. □ - 30MHz – 1	000MHz	
■ - PASS	□ - FAIL		APPLICABLE	
Minimum limit margin		>6 dB	At 30-300	MHz
Maximum limit exceeding			At	
Demonto.				
Remarks:				
Harmonic Current Emissions and Volta	age Fluctuation	s and Flicker		
□ - PASS	□ - FAIL	■ - NOT	APPLICABLE	
Harmonic measurement exceeding limit		Above	At	Harmonic
Flicker measurement exceeding limit		Above	The	Requirement
Remarks:				

Report Number: 708881569801-00-Part 1 Page 11 of 16



GENERAL REMARKS:

According to client's declaration, all the models have the same electric structure except for their different mechanical structure.

So model 182 was chosen to perform all the tests.

SUMMARY:		
All tests according to the regulations ci	ted on page 3 were	
■ - Performed		
□ - Not Performed		
The Equipment Under Test		
■ - Fulfills the general approval require	ements cited on page	3.
☐ - Does not fulfill the general approva	al requirements cited o	on page 3.
Testing Start Date:	May 22, 2015	<u> </u>
Testing End Date:	May 22, 2015	
- TÜV SÜD CERTIFICATION AND	TESTING (CHINA) C	O., LTD. SHANGHAI BRANCH-
Reviewed by:	Prepared t	by:
Liping XUE Review Engineer	12015 You	Yongqing ZHENG Project Engineer

Report Number: 708881569801-00-Part 1



Photograph of Test Setup: <u>Conducted Emissions: 9/150 kHz - 30 MHz</u>

■ - Test not applicable

Report Number: 708881569801-00-Part 1 Page 13 of 16



Photograph of Test Setup: Radiated Emissions 0.009MHz – 30MHz

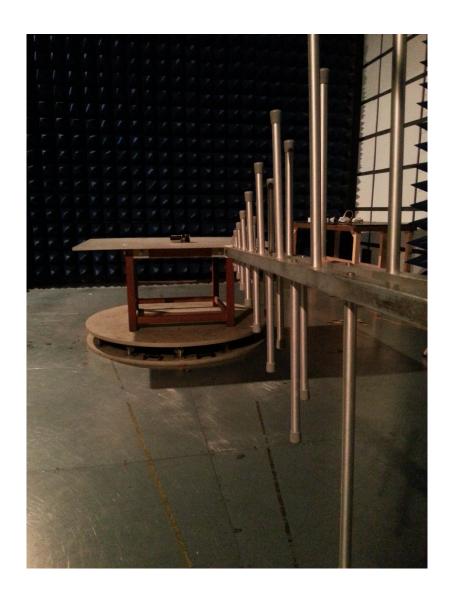
□ - Test not applicable





Photograph of Test Setup: Radiated Emissions 30 MHz – 300MHz

□ - Test not applicable





Photograph of Test Setup: <u>Harmonic Current/Voltage Fluctuations and Flicker</u>

■ - Test not applicable

Report Number: 708881569801-00-Part 1 Page 16 of 16

Rev. No. 14.01



Appendix A

Test Data Sheets

Report Number: 708881569801-00-Part 1 Page A1 of A6



9k-30MHz Radiated Emission Test

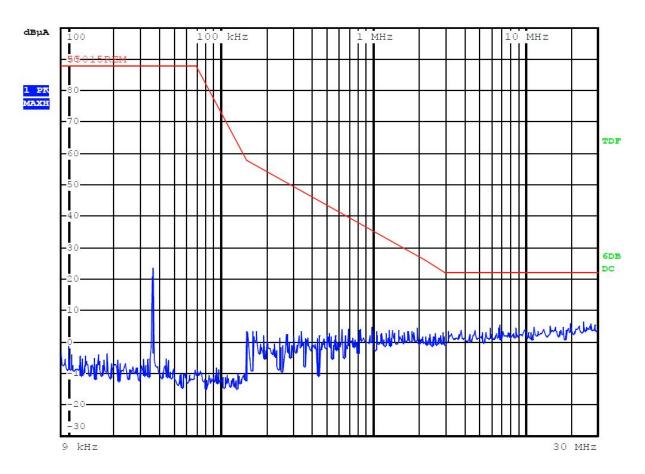
182

EUT: Flashlight

Manuf: Ningbo Strong Optoelectric Co., Ltd.

Op Cond: Light on Operator: Xiaoli Su EN55015 Sample No.: 171184-1

Comment: A1





9k-30MHz Radiated Emission Test

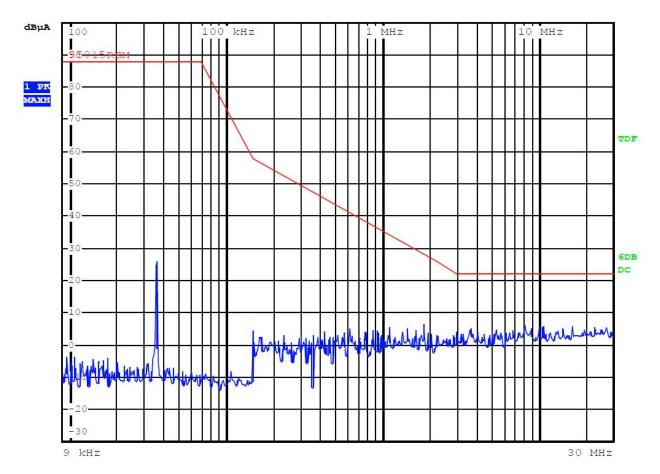
182

EUT: Flashlight

Manuf: Ningbo Strong Optoelectric Co., Ltd.

Op Cond: Light on Operator: Xiaoli Su Test Spec: EN55015 Sample No.: 171184-1

Comment: A2





9k-30MHz Radiated Emission Test

182

EUT: Flashlight

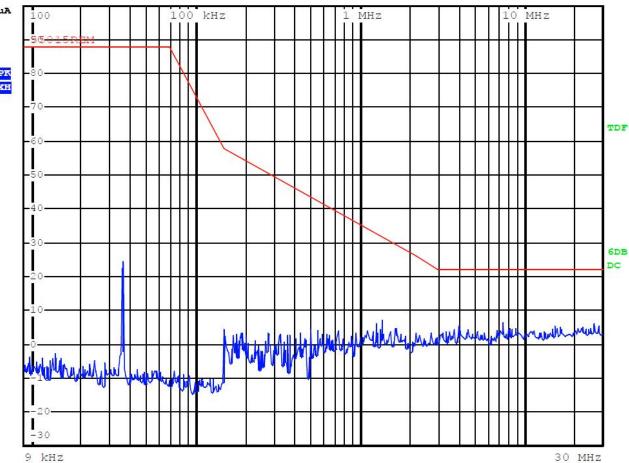
Manuf: Ningbo Strong Optoelectric Co., Ltd.

Op Cond: Light on Operator: Xiaoli Su Test Spec: EN55015 Sample No.: 171184-1

Comment: A3

dBµA







EMC32 Report

Common Information

Test Description: 30-300MHz Radiated Emission test

EUT: Flashlight; 182

Manufacturer Ningbo Strong Optoelectric Co.,Ltd.

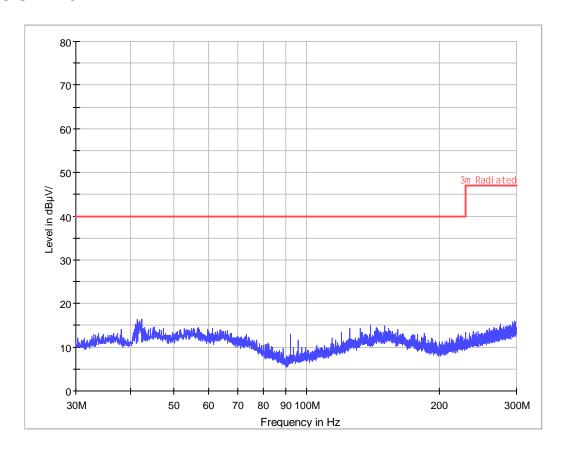
Operating Conditions: Light on
Operator Name: Xiaoli Su
Specification: EN 55015
Comment: Vertical
Sample No.: 171184-1

Automotive Setup: 3m 966 radiation(Scan) [EMI radiated]

Device Mode: Scan Mode

Subrange NameSubrangeStep SizeDetectorsIF BWMeas. TimeCISPR 1530 MHz - 300 MHz40 kHzPK+120 kHz0.005 s

CISPR 15



Report Number: 708881569801-00-Part 1 Page A5 of A6



EMC32 Report

Common Information

Test Description: 30-300MHz Radiated Emission test

EUT: Flashlight; 182

Manufacturer Ningbo Strong Optoelectric Co.,Ltd.

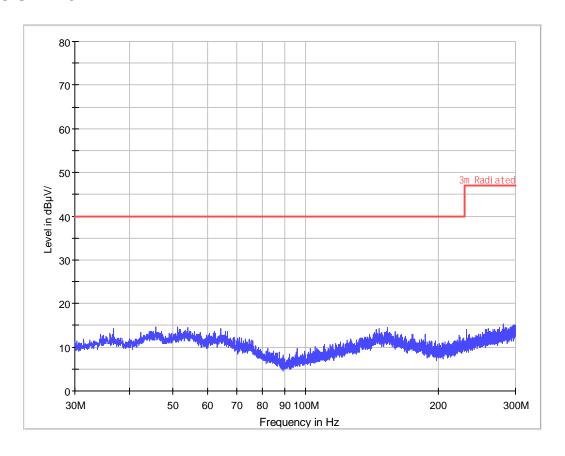
Operating Conditions: Power on Operator Name: Xiaoli Su Specification: EN 55015 Comment: Horizontal Sample No.: 171184-1

Automotive Setup: 3m 966 radiation(Scan) [EMI radiated]

Device Mode: Scan Mode

Subrange NameSubrangeStep SizeDetectorsIF BWMeas. TimeCISPR 1530 MHz - 300 MHz40 kHzPK+120 kHz0.005 s

CISPR 15



Report Number: 708881569801-00-Part 1 Page A6 of A6



Report Number: 708881569801-00-Part 1 Page A7 of A6



Appendix B <u>Data form for electrical equipment and machinery</u>

Applicant	: Ningbo Strong Optoelectric Co., Ltd.
Address	No.1, EAST YONGXING ROAD, EAST SUBURBS INDUSTRIAL ZONE, 315499 YUYAO, ZHEJIANG, PEOPLE'S REPUBLIC OF CHINA
Factory	: Same as above
Address	: Same as above
Туре	: Flashlight
Model	: XYZ (X stands for 1, 2, 3; Y stands for 0, 1, 2, 3, 4, 5, 6, 7, 8, 9; Z stands for 0, 1, 2, 3, 4, 5, 6, 7, 8, 9)
Rated voltage	: 4.2V DC
Rated power	: <u>7.56W</u>
Protection class	: <u>III</u>
LED, Switch, PCB Short description of Light equipment	f the EUT (Purpose of system, area of use, Function of the system):
Sources of Interfer	ence:
Internal frequencie	s:
Noise suppression	components:
Measures for elect	romagnetic shielding:

O If applicable, if necessary complete overlea

Report Number: 708881569801-00-Part 1 Page B1 of B3



Component List

Part No.	Information	No.
PCB	FR-4	
Resistor	10K,5%,0603	R1
Resistor	0.1Ω	R2, R3, R4
Diode	肖特基二极管,500mA,40V,SOD- 123 封装	S4
Capacitor	10UF, 10%, 0805	C1
IC	AT8PB513B,MCU,SOP8 封装	U1
Triode	230, N 沟道 MOS 管,4A,20V, SOT23 封装	Q1,Q2

Models List

101	201	301	121	221	141	161	181
102	202	302	122	222	142	162	182
103	203	303	123	223	143	163	183
104	204	304	124	224	144	164	184
105	205	305	125	225	145	165	185
106	206	306	126	226	146	166	186
107	207	307	127	227	147	167	187
108	208	308	128	228	148	168	188
109	209	309	129	229	149	169	189
110	210	310	130	230	150	170	190
111	211	311	131	231	151	171	191
112	212	312	132	232	152	172	192
113	213	313	133	233	153	173	193
114	214	314	134	234	154	174	194
115	215	315	135	235	155	175	195
116	216	316	136	236	156	176	196
117	217	317	137	237	157	177	197
118	218	318	138	238	158	178	198
119	219	319	139	239	159	179	199
120	220	320	140	240	160	180	200

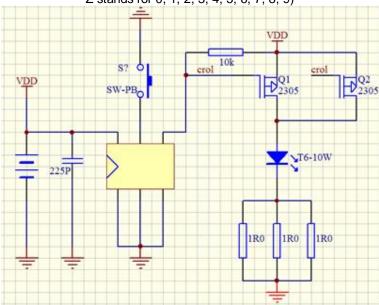
Report Number: 708881569801-00-Part 1 Page B2 of B3



Rev.No. 14.01

Circuit Diagram

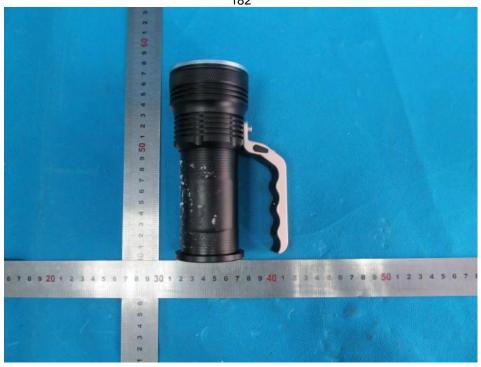
XYZ (X stands for 1, 2, 3; Y stands for 0, 1, 2, 3, 4, 5, 6, 7, 8, 9;
Z stands for 0, 1, 2, 3, 4, 5, 6, 7, 8, 9)





Appendix C



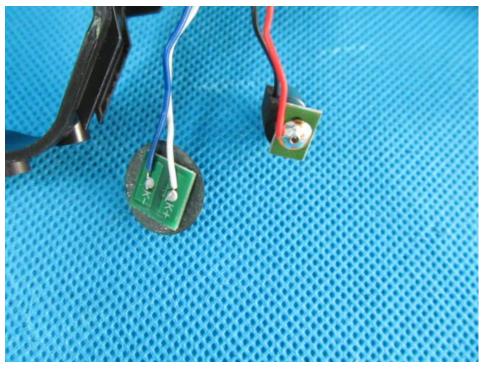






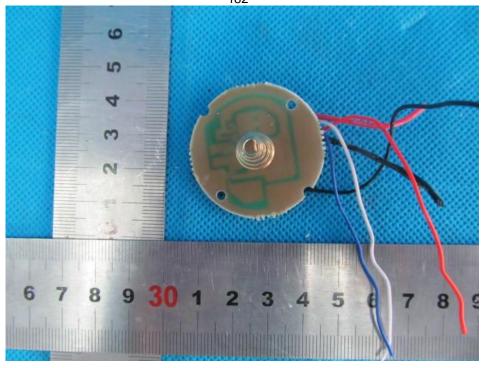
Constructional Photographs 182

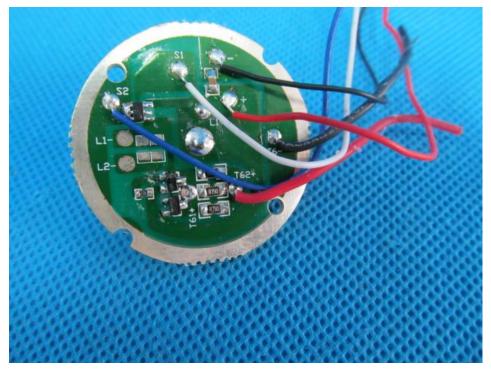






Constructional Photographs 182







EMC IMMUNITY TEST REPORT

Report Number 708881569801-00-Part 2 Date of Issue: June 15, 2015 XYZ (X stands for 1, 2, 3; Y stands for 0, 1, 2, 3, 4, 5, 6, 7, 8, 9; Z stands for 0, 1, 2, 3, 4, 5, 6, 7, 8, 9) Model Models list refer to Appendix B of 708881569801-00-Part 1 Product Type Flashlight **Applicant** Ningbo Strong Optoelectric Co., Ltd. Manufacturer Ningbo Strong Optoelectric Co., Ltd. License holder Ningbo Strong Optoelectric Co., Ltd. No.1, EAST YONGXING ROAD, Address EAST SUBURBS INDUSTRIAL ZONE 315499 YUYAO, ZHEJIANG, PEOPLE'S REPUBLIC OF CHINA

Test Result

Total pages including Appendices



TÜV SÜD CERTIFICATION AND TESTING (CHINA) CO., LTD. SHANGHAI BRANCH reports apply only to the specific samples tested under stated test conditions. Construction of the actual test samples has been documented. It is the manufacturer's responsibility to assure that additional production units of this model are manufactured with identical electrical and mechanical components. The manufacturer/importer is responsible to the Competent Authorities in Europe for any modifications made to the production units which result in non-compliance to the relevant regulations. TÜV SÜD Certification and Testing (China) Co., Ltd. Shanghai Branch shall have no liability for any deductions, inferences or generalizations drawn by the client or others from TÜV SÜD Certification and Testing (China) Co., Ltd. Shanghai Branch issued reports.

This report is the confidential property of the client. As a mutual protection to our clients, the public and ourselves, extracts from the test report shall not be reproduced except in full without our written approval.

Report Number: 708881569801-00-Part 2



DIRECTORY - IMMUNITY

		Pages
A)	Documentation	i agos
	Test Report	1 –16
	Directory	2
	Test Regulations	3
	General Remarks and Summary	16
	Test Setups (Photographs)	17-22
B)	Test data: Immunity against	
	Electrostatic Discharge	5
	Radiated Electromagnetic Fields	6
	Fast Transients (Burst)	7-8
	Surge Transients	9-10
	Conducted Disturbance	11-12
	RF Frequency Magnetic Fields	13
	Voltage Dips, Interruptions & Variations	14
C)	Appendix A	
	Constructional Data Form and Product Information Forms	A1
D)	Appendix B	
	Photo documents of EUT	B1



IMMUNITY TEST REGULATIONS:

The immunity tests were performed according to the following regulations:

■ - EMC	C - Directive	2004/108/EC	

□ - EN 61000-6-1: 2007

□ - EN 61000-6-2: 2005

□ - EN 55014-2: 1997+A1: 2001+A2: 2008

□ - EN 55020: 2007+A11: 2011

□ - EN 55024: 2010 □ - EN 61326-1: 2013

■ - EN 61547: 2009

■ - IEC 61000-4-2: 2008

■ - IEC 61000-4-3: 2006+A1:2007

□ - IEC 61000-4-4: 2004

□ - IEC 61000-4-5: 2005

□ - IEC 61000-4-6: 2008

□ - IEC 61000-4-8: 2003

□ - IEC 61000-4-11: 2004

Symbol Definitions:

- - Applicable
- □ Not Applicable

Note: For undated references, the latest edition of the publication at the time of testing (including amendments) was applied.

Report Number: 708881569801-00-Part 2 Page 3 of 22



Environmental Conditions In The Laboratory:

<u>Actual</u>

: 20 °C Temperature: Relative Humidity: : 50 % Atmospheric Pressure: : 1005 mBar

Power Supply Utilized:

: 4.2VDC Power supply system

Symbol Definitions:

■ - Applicable□ - Not Applicable

Report Number: 708881569801-00-Part 2 Page 4 of 22

Rev. No. 14.01



Immunity Test Conditions: ELECTROSTATIC DISCHARGE (ESD)

The immunity against *ELECTROSTATIC DISCHARGE (ESD)* events was performed in the following location:

□ - Test not applicable			
■ - Test Area -A			
Test Equipment Used : Model Number	Manufacturer	Description	TUV PS Number
■ - NSG435 ■ ■ □ - ONYX30 □ - PESD 3010 □	TESEQ TÜV Product Service TÜV Product Service Haefely Haefely	ESD Generator Horizontal Coupling Plane Vertical Coupling Plane ESD Simulator System ESD Simulator System	487/751016 487/751520 487/750508
Remarks: Test equipment	t used is calibrated on a re	egular basis.	
Test Specification: Discharge Voltage (Air):	□ - 2 kV □ - 4 kV	■ - 8 kV □ - 15 kV	□ - 6 kV □ kV
Discharge Voltage (Contact	<u>t)</u> : □ - 2 kV ■- 4 kV	□ - 6 kV □ - 8 kV	□ kV
Discharge Impedance:	■ - 330 Ω / 150 p	pF 🔲 - 150 Ω / 150 pF	
Discharge Repetition Rate:	■ - ≥ 1 sec.		
Number of Discharges:	■ - ≥ 10 at all loc	cations	
Kind of Discharges:	■ - Air discharge ■ - Direct	e ■ - Conducted discha ■ - Indirect	arge (relay)
Polarity:	■ - Positive	■ - Negative	
Location of Discharge:		ecord(s) in Appendix A n on the surface touchable by in Appendix A	hand
Result: ■ - No degradation of funct □ - Distortion of function □ - Error of function □ - Loss of function	ion - Met Criterion A - Met Criterion E - Met Criterion C - Unrecoverable	3 C	
Remarks:			_

Report Number: 708881569801-00-Part 2 Page 5 of 22



Immunity Test Conditions: RADIATED ELECTROMAGNETIC FIELDS

The immunity against RADIATED ELECTROMAGNETIC FIELDS exposure was performed in the following location:

☐ - Test not applicable				
■ - Test Area -A				
Test Equipment Used:	Schwa Rohde Amplifi Rohde Amplifi Amplifi Amplifi Schwa ROHD Amplifi ROHDI	acturer Irzbeck & Schwarz Ier Research & Schwarz Ier Research Irzbeck E&SCHWARZ IER SCHWARZ E & SCHWARZ E & SCHWARZ E adlibrated on a regular	Description Antenna Signal Generator Power Amplifier Power Meter Power Amplifier Coupler Coupler Log-periodic Antenna Horn Antenna Signal Generator Horn Antenna EMS Test System Stripline basis.	TUV PS Number 487/621432 487/391120 487/400909 487/741156 487/400908 487/570202 487/571116 487/620519 487/620213 487/390304 487/620621 487/620315
T . 6 'E' .'				
Test Specification: Frequency Range:		□ - 27 MHz - 500 MHz	□ - 26 MHz - 1000 M	H ₇
rroquonoy rtungo.		□ - 9 kHz - 27 MHz	■ - 80 MHz - 1000 MH	· · =
Field Strength:		□ - 1 V/m □ - 10 V/m	■ - 3 V/m □ V/m	
Distance Antenna - EUT:		□ - 1 m	■ - 3 m	
Modulation:		■ - AM : □ - FM : ■ - sine wave:	80 % kHz dev.	1 kHz kHz
		□ - unmodulated□ - Pulse	ON/OFF	Duty Cycle: %
Step:		■ - 1%		
Polarization of Antenna:		■ - Horizontal	■ - Vertical	
Result: ■ - No degradation of function □ - Distortion of function □ - Error of function □ - Loss of function	1	- Met Criterion A - Met Criterion B - Met Criterion C - Unrecoverable Failur	е	
Remarks:				



Immunity Test Conditions: FAST TRANSIENTS (BURST)

The immunity against FAST TRANSIENTS (BURST) events was performed in the following test location:

- 7	est not applicable						
- - ⁻	Гest Area -						
Test	Equipment Used : Model Number	Manufad	cturer	Description	ı	TUV PS Number	
	UCS 500N5E	EM Test		EFT/Burst G		487/751219	
	CDN125	Schaffne	er		Coupling Clamp	48-7/60-99-08	
□ -	CNI 503	EM Test			pling network	487/609909	
□ -	NSG2050	Schaffne		EFT/Burst G		487/390203	
□ -	PNW2225	Schaffne	er	Fast Transie	ent/Burst Plug-in	487/610205	
Rem	arks: Test equipment	used is o	calibrated on	a regular ba	asis.		
	Specification: e Amplitude - AC Pow	<u>er Port</u> :	□ - 1,0 kV □ - 4,0 kV		□ - 2,0 kV □ kV		
<u>Puls</u>	e Amplitude - DC Pow	er Port:	□ - 1,0 kV □ - 4,0 kV		□ - 2,0 kV □ kV		
	e Amplitude - Signal/D n control Port:	oata (□ - 0,5 kV □ - 2,0 kV		□ - 1,0 kV □ kV		
	e Amplitude - Process: asurement & Control Po		□ - 0,5 kV □ - 2,0 kV		□ - 1,0 kV □ kV		
<u>Burs</u>	t Frequency:		□ - 2,5 kHz		□ - 5,0 kHz	□ kHz	
<u>Time</u>	of Coupling:		□ - 60 seco	onds	□ - 120 seconds		
<u>Cou</u> p	oling Method:		☐ - Coupling	g/decoupling	network	□ - Coupling clamp	
<u>Pola</u>	rity:		☐ - Positive		□ - Negative		

Report Number: 708881569801-00-Part 2 Page 7 of 22



Immunity Test Conditions: FAST TRANSIENTS (BURST), continued

Location of Coupling:		
name of lines: type of lines: status of lines: kind of transmission: length of lines:	□ - shielded □ - passive □ - analog	☐ - unshielded ☐ - active ☐ - digital
name of lines: type of lines: status of lines: kind of transmission: length of lines:	□ - shielded □ - passive □ - analog	□ - unshielded □ - active □ - digital
name of lines: type of lines: status of lines: kind of transmission: length of lines:	□ - shielded □ - passive □ - analog	☐ - unshielded ☐ - active ☐ - digital
Result: ☐ - No degradation of function ☐ - Distortion of function ☐ - Error of function ☐ - Loss of function	Met Criterion AMet Criterion BMet Criterion CUnrecoverable Failure	
Remarks:		



Immunity Test Conditions: SURGE TRANSIENTS

■ - Test not applicable

The immunity against SURGE TRANSIENTS events was performed in the following test location:

□ - Test Area -						
	Equipment Used : Model Number	Manufac		Descriptio		TUV PS Number
	UCS 500N5V CNI 503	EM Test EM Test		Surge General Su	erator upling network	487/751218 487/609909
Rem	arks: Test equipment	used is c	alibrated on a	a regular ba	asis.	
	Specification: e Amplitude - AC Powe	er Port:	☐ - 1,0 kV (phase and pl (phase and no ☐ - 4,0 kV		☐ - 2,0 kV (phase and protecti (neutral and protecti ☐ - 0,5 kV	
<u>Pulse</u>	e Amplitude - DC Powe	er Port:	□ - 1,0 kV □ - 4,0 kV		□ - 2,0 kV □ kV	
	e Amplitude - Signal/D n control Port:	<u>ata</u>	□ - 0,5 kV □ - 2,0 kV		□ - 1,0 kV □ kV	
Pulse Amplitude - Process: Measurement & Control Port			□ - 0,5 kV □ - 2,0 kV		□ - 1,0 kV □ kV	
Sour	ce Impedance:		\Box - 2 Ω + 18 (phase and plotphase and no \Box - 42 Ω + 0,	hase) eutral)	\Box - 12 Ω + 9 μF (phase and protection (neutral and protection - 42 Ω + 0,5 μF	
<u>Num</u>	ber of Surges:		□ - 10 surges	s/angle	□ surges /angle	е
Angle	<u>e:</u>		□ - 0 ° □ - 270 °		□ - 90°	
Repe	etition Rate:		□ - 60 sec.		□ sec.	
<u>Pola</u>	<u>rity:</u>		□- Positive		□ - Negative	

Report Number: 708881569801-00-Part 2 Page 9 of 22



Immunity Test Conditions: SURGE TRANSIENTS, continued

Location of Coupling:				
name of lines: type of lines: status of lines: kind of transmission: length of lines:		□ - shielded □ - passive □ - analog	☐ - unshielded☐ - active☐ - digital☐ -	
name of lines: type of lines: status of lines: kind of transmission: length of lines:		□ - shielded □ - passive □ - analog	☐ - unshielded☐ - active☐ - digital☐ -	
name of lines: type of lines: status of lines: kind of transmission: length of lines:		☐ - shielded ☐ - passive ☐ - analog	□ - unshielded □ - active □ - digital	
Result: ☐ - No degradation of function ☐ - Distortion of function ☐ - Error of function ☐ - Loss of function	- Met Criter - Met Criter	ion B		
Remarks:				



Immunity Test Conditions: CONDUCTED DISTURBANCE

The immunity against *Conducted Disturbance* events, induced by radio frequency fields above 9 kHz, was performed in the following test location:

■ - 7	Test not applicable				
п-	Test Area -				
_	103171100				
Test	Equipment Used :				
	Model Number		facturer	Description	TUV PS Number
	NSG 2070	Schaff	ner	RF-Generator	48-7/75-99-01
□ -	CDN725	Schaff	ner	EM Clamp	48-7/60-99-02
□ -	INA726	Schaff	ner	De-coupling Clamp	48-7/60-99-03
□ -	CDN M2	Schaff	ner	Coupling/decoupling Network	48-7/60-99-05
□ -	CDN M3	Schaff	ner	Coupling/decoupling Network	48-7/60-99-06
□ -	MD720	Schaff	ner	Monitoring Probe	48-7/60-99-07
	Specification:		= 0.45.44		
<u>Frec</u>	<u>juency Range</u> :		□ - 0,15 MHz - 230) MHz	□ - 0,15 MHz - 80 MHz
<u>Volta</u>	age Level (EMF):		□ - 1 V □ - 10 V	□ - 3 V □ V	
<u>Mod</u>	ulation:		□ - AM : □ - FM : □ - sine wave:	<u>80</u> % kHz dev.	1_ kHz kHz
			□ - unmodulated□ - Pulse	ON/OFF	Duty Cycle: %
Step	<u>):</u>		□- 1%		

Report Number: 708881569801-00-Part 2 Page 11 of 22



Immunity Test Conditions: CONDUCTED DISTURBANCE, continued

Location of Coupling:		
name of lines: type of lines: status of lines: kind of transmission: length of lines:	□ - shielded □ - passive □ - analog	_ □- unshielded □ - active □ - digital
name of lines: type of lines: status of lines: kind of transmission: length of lines:	□ - shielded □ - passive □ - analog	_ □ - unshielded □ - active □ - digital _
name of lines: type of lines: status of lines: kind of transmission: length of lines:	□ - shielded □ - passive □ - analog	_ □ - unshielded □ - active □ - digital −
Result: ☐ - No degradation of function ☐ - Distortion of function ☐ - Error of function ☐ - Loss of function	on - Met Criterion A - Met Criterion B - Met Criterion C - Unrecoverable Failure	
Remarks:		



Immunity Test Conditions: POWER FREQUENCY MAGNETIC FIELD

The immunity against *POWER FREQUENCY MAGNETIC FIELD* exposure, induced by power frequency magnetic fields, was performed in the following test location:

■ - Test not applicable				
□ - Test Area -				
Test Equipment Used : Model Number	Manufacturer	Description	TUV PS Number	
□ - INA702 □ - INA2141 □ - 4500L	Schaffner Schaffner California Instrument	Magnetic Field Coil Induction Coil Interface Power Source	487/440201 487/440202 707/689501	
Remarks: Test equipment	t used is calibrated on a	regular basis.		
Test Specification: Frequency Range:	□ - 50 Hz	□ - 60 Hz	□ - 400 Hz	
Field level (EMF):	□ - 1 A/m □ - 30 A/m	□ - 3 A/m □ - 100 A/m	□ - 10 A/m □ A/m	
Short Field (1-3 sec):	□ - 300 A/m	□ - 1000 A/m	□ A/m	
Duration:	□ second	s		
Axis of Orientation:	□ - X-axis	□ - Y-axis	□ - Z-axis	
Result: ☐ - No degradation of function ☐ - Distortion of function ☐ - Error of function ☐ - Loss of function ☐ - Loss of function ☐ - Unrecoverable Failure				
Remarks:				



Immunity Test Conditions: VOLTAGE DIPS, INTERRUPTIONS & VARIATIONS

The immunity against *Voltage Dips, Interruptions & Variations* events, induced by radio frequency fields above 9 kHz, was performed in the following test location:

■ - Test not applicable				
□ - Test Area -				
Test Equipment Used :	Manufactur Schaffner EM test California Instruments	Drop-out and V Voltage Drop G AC Power Sup	pply Testing System	TUV PS Number 70-7/75-96-04 487/751117 487/68-99-10
Remarks: Test equipm	ent used is t	calibrated on a regular b	Jasis.	
Test Specification: Nominal Mains Voltage (•	□ - 230 Vac	□ Vac	□ Vdc
Level of Reduction (dip):		☐ - 1000 ms voltage dips☐ - 200 ms voltage d	in 60% of U _T	
<u>Duration of Interruption</u> ((>.95*U _T):	□ - 5000 ms	□ - <u>10</u> ms	
Voltage Fluctuation:		□ - U _T + 10%	□ - U _T - 10%	
Result: ☐ - No degradation of fu ☐ - Distortion of function ☐ - Error of function ☐ - Loss of function		- Met Criterion A - Met Criterion B - Met Criterion C - Unrecoverable Failure)	
Remarks:				



Equipment Under Test (EUT) Test Operation Mode - Immunity Tests:

The equipment under test was	perated under the following conditions during immunity testing:
□ - Standby	
□ - Test Program (H - Pattern)	
□ - Test Program (Color Bar)	
☐ - Test Program (Customer Spe	ified)
■ - Normal Operating Mode	
■ - Light on.	
Configuration of the equipmen	under test
See Constructional Data Forr	in Appendix A
■ - See Product Information Form	s) in Appendix A
The following peripheral device	s and interface cables were connected during the testing:
The following peripheral device	and interface capies were connected during the testing.
o	Туре :
o	
-	
o-	
O-	
o -	
o -	
□ - unshielded power cable	
□ - unshielded cables	
□ - shielded cables	TÜVPS. No.:
☐ - customer specific cables	
П-	



GENERAL REMARKS:

According to client's declaration, all the models have the same electric structure except for their different mechanical structure.

So model 182 was chosen to perform all the tests.

SUMMARY:		
All tests according to the regulations cit	ed on page 3 were	
■ - Performed		
□ - Not Performed		
The Equipment Under Test		
■ - Fulfills the general approval require	ements cited on page	3.
☐ - Does not fulfill the general approva	l requirements cited	on page 3.
Testing Start Date:	May 22, 2015	
Testing End Date:	May 22, 2015	·
	CTID CHINA	5
- TÜV SÜD CERTIFICATION AND 1	TESTING CHINA	CO., LTD. SHANGHAI BRANCH-
	500	
Reviewed by:		ared by:
Liping XUE	1,2015	Yongqing2heng 6-15, 2015 YongqingZHENG
Řeview Engineer		Project Engineer

Report Number: 708881569801-00-Part 2

Page 16 of 22

Rev. No. 14.01

Project Engineer



Photograph of Test Setup: Electrostatic Discharge (ESD)

□ - Test not applicable

IEC 61000-4-2 EN 61000-4-2

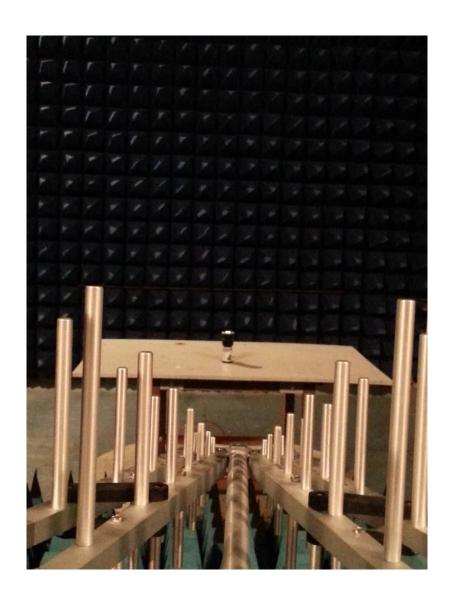




Photograph of Test Setup: Radiated Electromagnetic Field

□ - Test not applicable

IEC 61000-4-3 EN 61000-4-3





Photograph of Test Setup: Fast transients (BURST)

■ - Test not applicable

IEC 61000-4-4 EN 61000-4-4

Report Number: 708881569801-00-Part 2 Page 19 of 22



Photograph of Test Setup: SURGE transients

■ - Test not applicable

IEC 61000-4-5 EN 61000-4-5

Report Number: 708881569801-00-Part 2 Page 20 of 22

Rev. No. 14.01



Photograph of Test Setup: Conducted disturbance

■ - Test not applicable

IEC 61000-4-6 EN 61000-4-6

Report Number: 708881569801-00-Part 2 Page 21 of 22



Photograph of Test Setup: Voltage Dips, Interruptions & Variations

■ - Test not applicable

IEC 61000-4-11 EN 61000-4-11

Report Number: 708881569801-00-Part 2 Page 22 of 22



Appendix A

Constructional Data Form

and

Product Information Form(s)

Please refer to EMC EMISSION-TEST REPORT Appendix B

Report Number: 708881569801-00-Part 2 Page A1of A1

Rev. No. 14.01



Appendix B

Photo documents

of

Equipment Under Test (EUT)

Please refer to EMC EMISSION-TEST REPORT Appendix C

Report Number: 708881569801-00-Part 2 Page B1 of B1